

Notice of References Cited	Application/Control No. 10/052,255	Applicant(s)/Patent Under Reexamination EBINA ET AL.	
	Examiner Scott B. Geyer	Art Unit 2829	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6521495 B2	02-2003	Shone et al.	438/257
	B	US-6518124 B1	02-2003	Ebina et al.	438/257
	C	US-6451643 B2	09-2002	Komori et al.	438/211
	D	US-6413821 B1	07-2002	Ebina et al.	438/257
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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